

Issue Classification	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10629020	EZELL, R. WILLIAM
Examiner	Art Unit	
Lee, Siu M	2611	

Lee, Siu M (Assistant Examiner)	8/3/2007 (Date)	<i>Chieh M. Fan</i>	Total Claims Allowed: 20	
(Legal Instruments Examiner)	(Date)	CHIEH M. FAN SUPERVISORY PATENT EXAMINER (Primary Examiner) <i>8/3/07</i> (Date)	O.G. Print Claim(s) 1	O.G. Print Figure 4